

# SIPMOS® Small-Signal-Transistor

## Features

- N-channel
- Enhancement mode
- Logic level
- dv/dt rated
- Pb-free lead-plating; RoHS compliant
- Qualified according to AEC Q101
- Halogen free according to IEC61249-2-21

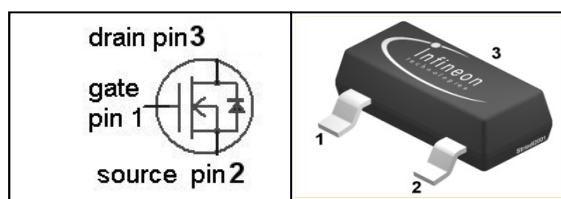


Halogen-Free

## Product Summary

|                  |      |          |
|------------------|------|----------|
| $V_{DS}$         | 60   | V        |
| $R_{DS(on),max}$ | 3.5  | $\Omega$ |
| $I_D$            | 0.23 | A        |

## PG-SOT-23



| Type    | Package   | Tape and Reel | Marking |
|---------|-----------|---------------|---------|
| BSS138N | PG-SOT-23 | H6327: 3000   | SKs     |
| BSS138N | PG-SOT-23 | H6433: 10000  | SKs     |

| Parameter                           | Symbol            | Conditions                                                                                                      | Value           | Unit              |
|-------------------------------------|-------------------|-----------------------------------------------------------------------------------------------------------------|-----------------|-------------------|
| Continuous drain current            | $I_D$             | $T_A=25\text{ °C}$                                                                                              | 0.23            | A                 |
|                                     |                   | $T_A=70\text{ °C}$                                                                                              | 0.18            |                   |
| Pulsed drain current                | $I_{D,pulse}$     | $T_A=25\text{ °C}$                                                                                              | 0.92            |                   |
| Reverse diode dv/dt                 | dv/dt             | $I_D=0.23\text{ A}$ , $V_{DS}=48\text{ V}$ ,<br>$di/dt=200\text{ A}/\mu\text{s}$ ,<br>$T_{j,max}=150\text{ °C}$ | 6               | kV/ $\mu\text{s}$ |
| Gate source voltage                 | $V_{GS}$          |                                                                                                                 | $\pm 20$        | V                 |
| ESD sensitivity                     |                   | JESD22-A114 (HBM)                                                                                               | Class 0 (<250V) |                   |
| Power dissipation                   | $P_{tot}$         | $T_A=25\text{ °C}$                                                                                              | 0.36            | W                 |
| Operating and storage temperature   | $T_j$ , $T_{stg}$ |                                                                                                                 | -55 ... 150     | °C                |
| IEC climatic category; DIN IEC 68-1 |                   |                                                                                                                 | 55/150/56       |                   |

| Parameter | Symbol | Conditions | Values |      |      | Unit |
|-----------|--------|------------|--------|------|------|------|
|           |        |            | min.   | typ. | max. |      |

**Thermal characteristics**

|                                                     |            |  |   |   |     |     |
|-----------------------------------------------------|------------|--|---|---|-----|-----|
| Thermal resistance,<br>junction - minimal footprint | $R_{thJA}$ |  | - | - | 350 | K/W |
|-----------------------------------------------------|------------|--|---|---|-----|-----|

**Electrical characteristics, at  $T_j=25\text{ °C}$ , unless otherwise specified**
**Static characteristics**

|                                  |               |                                                                 |     |     |     |               |
|----------------------------------|---------------|-----------------------------------------------------------------|-----|-----|-----|---------------|
| Drain-source breakdown voltage   | $V_{(BR)DSS}$ | $V_{GS}=0\text{ V}, I_D=250\text{ }\mu\text{A}$                 | 60  | -   | -   | V             |
| Gate threshold voltage           | $V_{GS(th)}$  | $V_{GS}=V_{DS}, I_D=26\text{ }\mu\text{A}$                      | 0.6 | 1.0 | 1.4 |               |
| Drain-source leakage current     | $I_{D(off)}$  | $V_{DS}=60\text{ V},$<br>$V_{GS}=0\text{ V}, T_j=25\text{ °C}$  | -   | -   | 0.1 | $\mu\text{A}$ |
|                                  |               | $V_{DS}=60\text{ V},$<br>$V_{GS}=0\text{ V}, T_j=150\text{ °C}$ | -   | -   | 5   |               |
| Gate-source leakage current      | $I_{GSS}$     | $V_{GS}=20\text{ V}, V_{DS}=0\text{ V}$                         | -   | 1   | 10  | nA            |
| Drain-source on-state resistance | $R_{DS(on)}$  | $V_{GS}=4.5\text{ V}, I_D=0.03\text{ A}$                        | -   | 3.3 | 4.0 | $\Omega$      |
|                                  |               | $V_{GS}=4.5\text{ V}, I_D=0.19\text{ A}$                        | -   | 3.5 | 6.0 |               |
|                                  |               | $V_{GS}=10\text{ V}, I_D=0.23\text{ A}$                         | -   | 2.2 | 3.5 |               |
| Transconductance                 | $g_{fs}$      | $ V_{DS} >2 I_D R_{DS(on)max},$<br>$I_D=0.18\text{ A}$          | 0.1 | 0.2 | -   | S             |

| Parameter | Symbol | Conditions | Values |      |      | Unit |
|-----------|--------|------------|--------|------|------|------|
|           |        |            | min.   | typ. | max. |      |

**Dynamic characteristics**

|                              |              |                                                                                 |   |     |      |    |
|------------------------------|--------------|---------------------------------------------------------------------------------|---|-----|------|----|
| Input capacitance            | $C_{iss}$    | $V_{GS}=0\text{ V}, V_{DS}=25\text{ V},$<br>$f=1\text{ MHz}$                    | - | 32  | 41   | pF |
| Output capacitance           | $C_{oss}$    |                                                                                 | - | 7.2 | 9.5  |    |
| Reverse transfer capacitance | $C_{rss}$    |                                                                                 | - | 2.8 | 3.8  |    |
| Turn-on delay time           | $t_{d(on)}$  | $V_{DD}=30\text{ V}, V_{GS}=10\text{ V},$<br>$I_D=0.23\text{ A}, R_G=6\ \Omega$ | - | 2.3 | 3.5  | ns |
| Rise time                    | $t_r$        |                                                                                 | - | 3.0 | 4.5  |    |
| Turn-off delay time          | $t_{d(off)}$ |                                                                                 | - | 6.7 | 10   |    |
| Fall time                    | $t_f$        |                                                                                 | - | 8.2 | 12.3 |    |

**Gate Charge Characteristics**

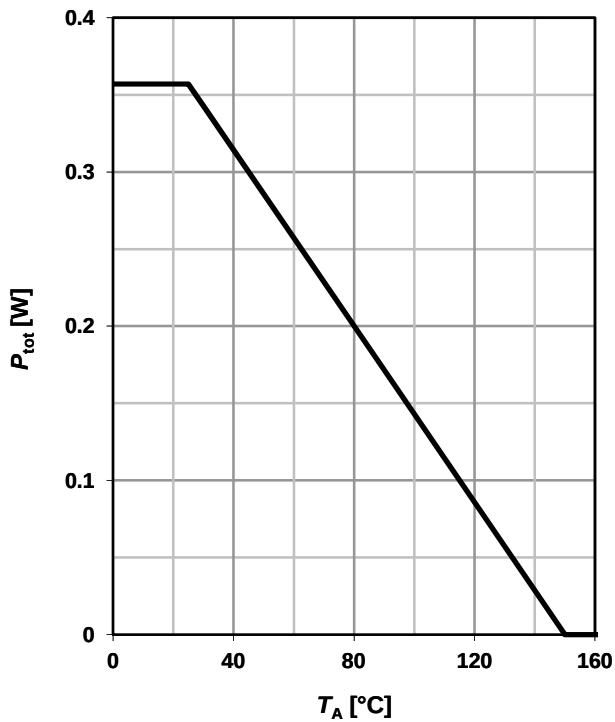
|                       |               |                                                                              |   |      |      |    |
|-----------------------|---------------|------------------------------------------------------------------------------|---|------|------|----|
| Gate to source charge | $Q_{gs}$      | $V_{DD}=48\text{ V}, I_D=0.23\text{ A},$<br>$V_{GS}=0\text{ to }10\text{ V}$ | - | 0.10 | 0.14 | nC |
| Gate to drain charge  | $Q_{gd}$      |                                                                              | - | 0.3  | 0.4  |    |
| Gate charge total     | $Q_g$         |                                                                              | - | 1.0  | 1.4  |    |
| Gate plateau voltage  | $V_{plateau}$ |                                                                              | - | 3.3  | -    | V  |

**Reverse Diode**

|                                  |               |                                                                             |   |      |      |    |
|----------------------------------|---------------|-----------------------------------------------------------------------------|---|------|------|----|
| Diode continuous forward current | $I_S$         | $T_A=25\text{ °C}$                                                          | - | -    | 0.23 | A  |
| Diode pulse current              | $I_{S,pulse}$ |                                                                             | - | -    | 0.92 |    |
| Diode forward voltage            | $V_{SD}$      | $V_{GS}=0\text{ V}, I_F=0.23\text{ A},$<br>$T_J=25\text{ °C}$               | - | 0.83 | 1.2  | V  |
| Reverse recovery time            | $t_{rr}$      | $V_R=30\text{ V}, I_F=0.23\text{ A},$<br>$di_F/dt=100\text{ A}/\mu\text{s}$ | - | 9.1  | 14.5 | ns |
| Reverse recovery charge          | $Q_{rr}$      |                                                                             | - | 3.3  | 5    | nC |

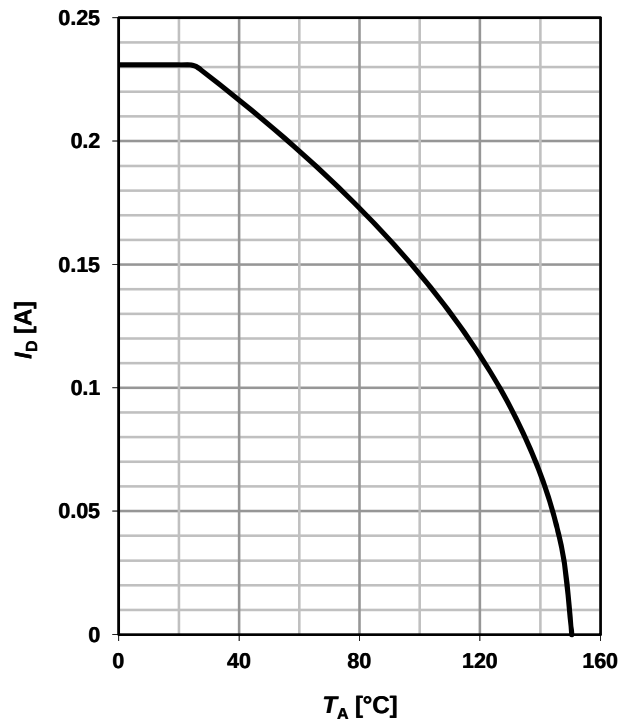
### 1 Power dissipation

$$P_{\text{tot}} = f(T_A)$$



### 2 Drain current

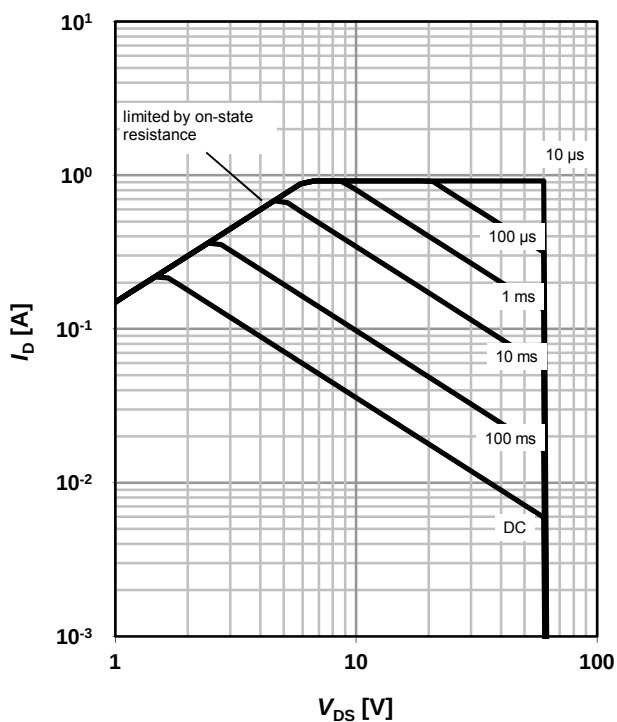
$$I_D = f(T_A); V_{GS} \geq 10 \text{ V}$$



### 3 Safe operating area

$$I_D = f(V_{DS}); T_A = 25 \text{ °C}; D = 0$$

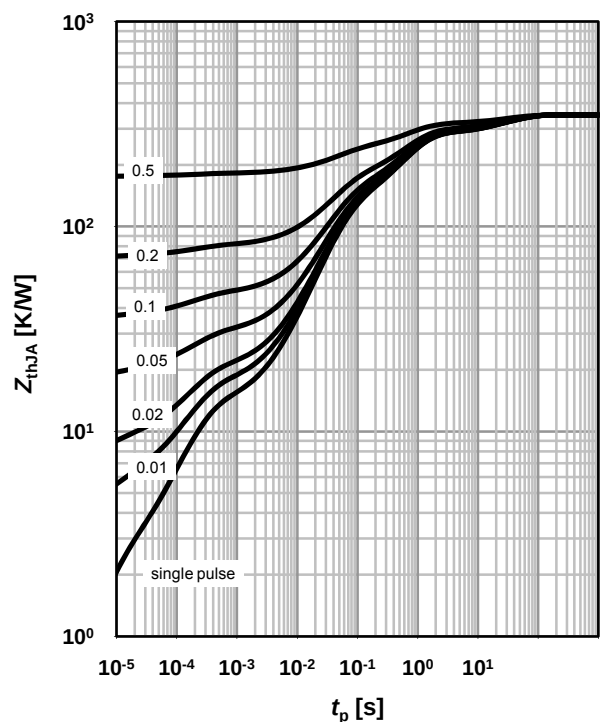
parameter:  $t_p$



### 4 Max. transient thermal impedance

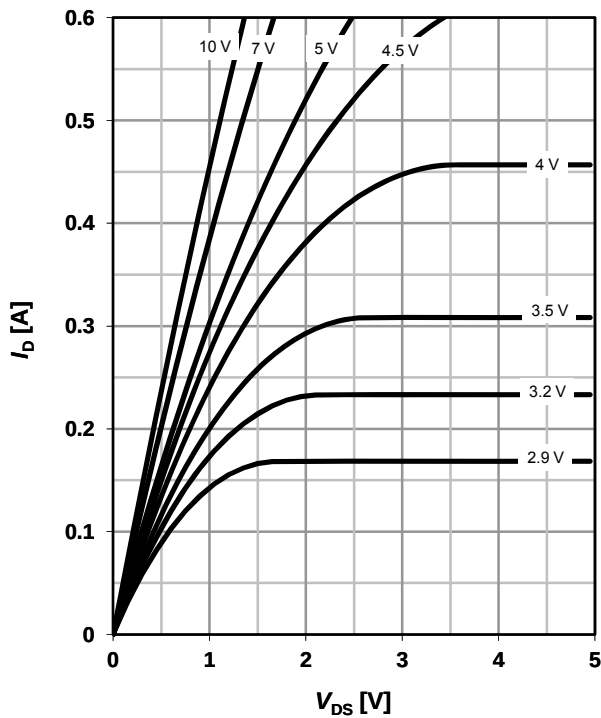
$$Z_{thJA} = f(t_p)$$

parameter:  $D = t_p / T$



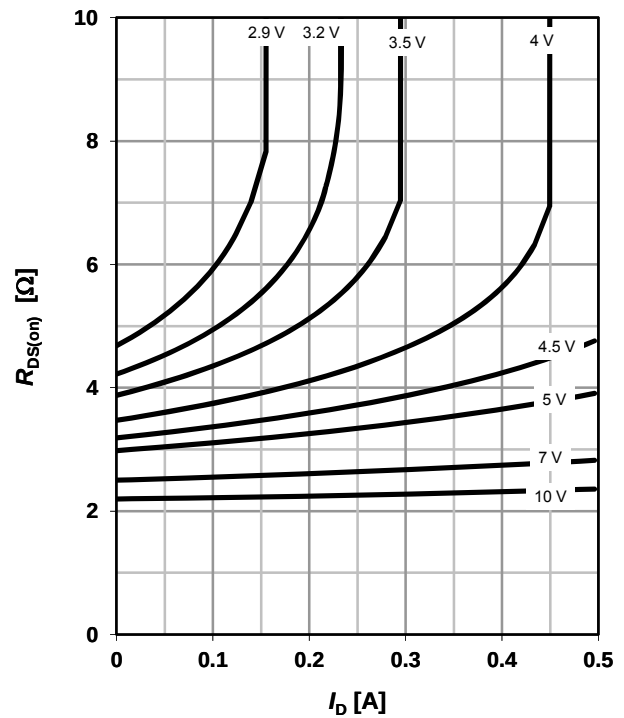
### 5 Typ. output characteristics

 $I_D = f(V_{DS}); T_j = 25^\circ\text{C}$ 

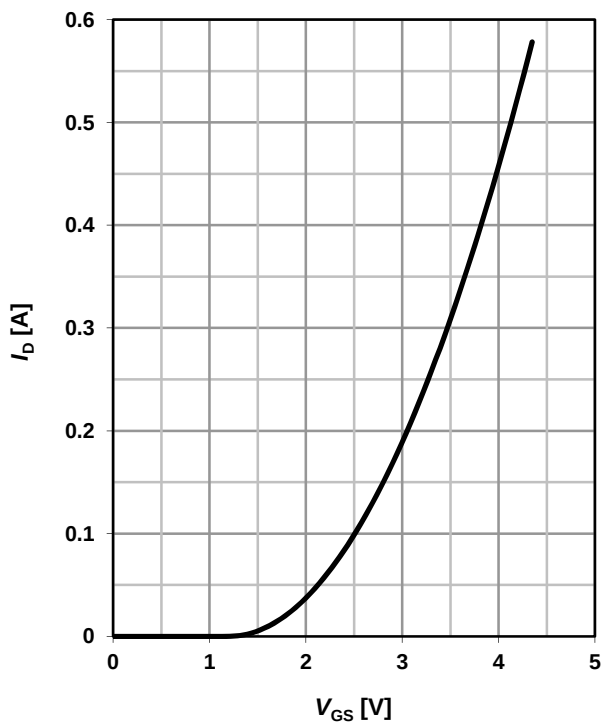
parameter:  $V_{GS}$ 


### 6 Typ. drain-source on resistance

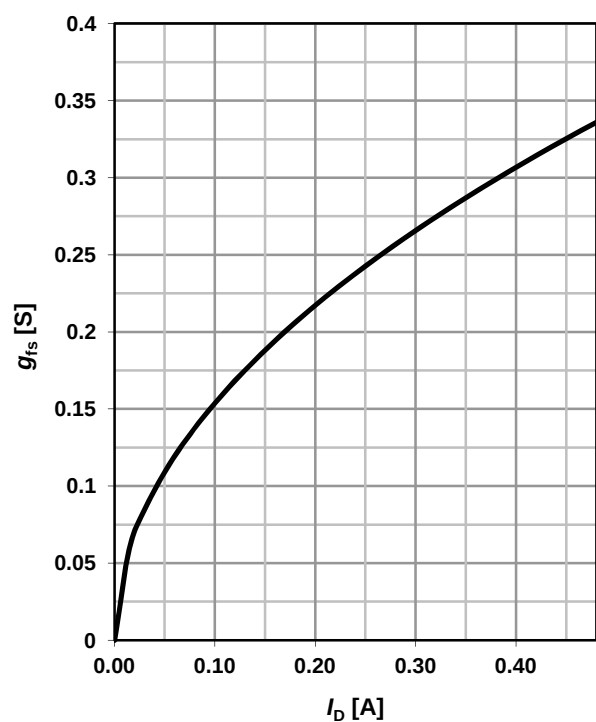
 $R_{DS(on)} = f(I_D); T_j = 25^\circ\text{C}$ 

parameter:  $V_{GS}$ 


### 7 Typ. transfer characteristics

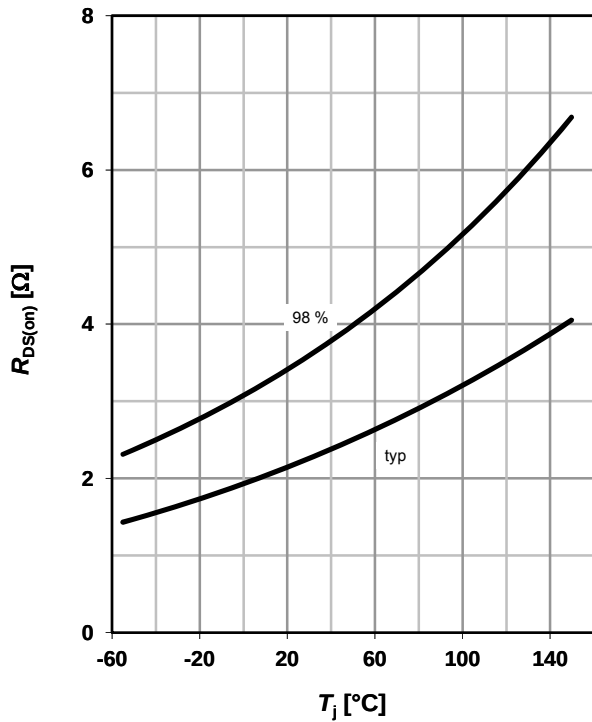
 $I_D = f(V_{GS}); |V_{DS}| > 2|I_D|R_{DS(on)max}$ 


### 8 Typ. forward transconductance

 $g_{fs} = f(I_D); T_j = 25^\circ\text{C}$ 


### 9 Drain-source on-state resistance

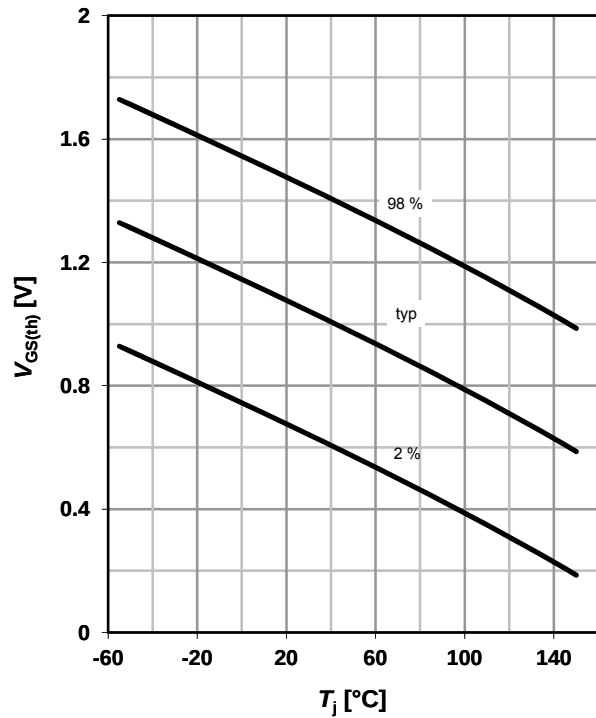
$R_{DS(on)} = f(T_j)$ ;  $I_D = 0.23 \text{ A}$ ;  $V_{GS} = 10 \text{ V}$



### 10 Typ. gate threshold voltage

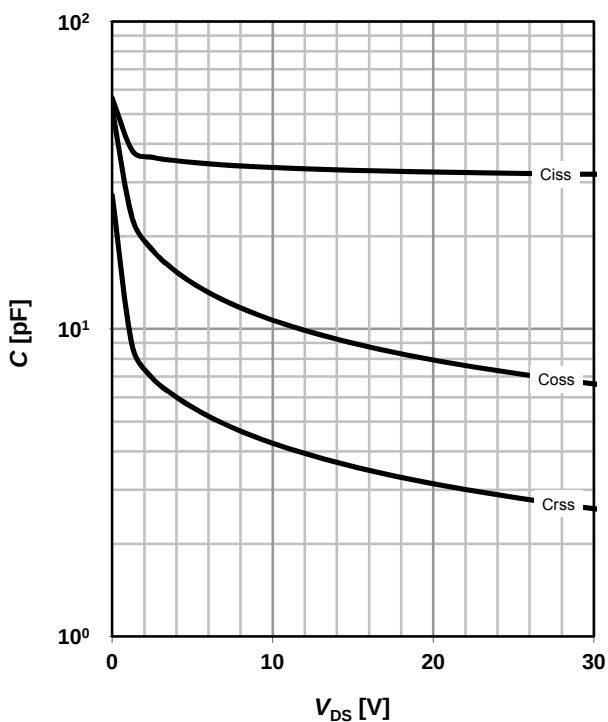
$V_{GS(th)} = f(T_j)$ ;  $V_{DS} = V_{GS}$ ;  $I_D = 26 \mu\text{A}$

parameter:  $I_D$



### 11 Typ. capacitances

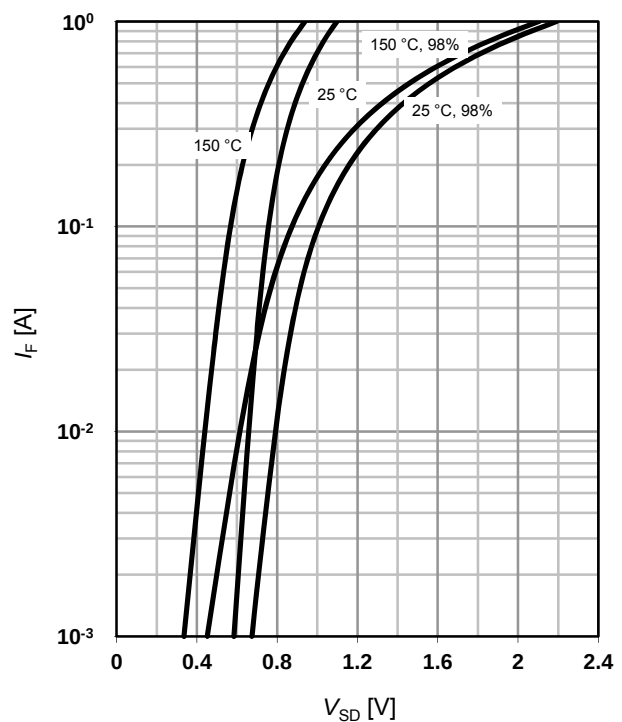
$C = f(V_{DS})$ ;  $V_{GS} = 0 \text{ V}$ ;  $f = 1 \text{ MHz}$ ;  $T_j = 25^\circ\text{C}$



### 12 Forward characteristics of reverse diode

$I_F = f(V_{SD})$

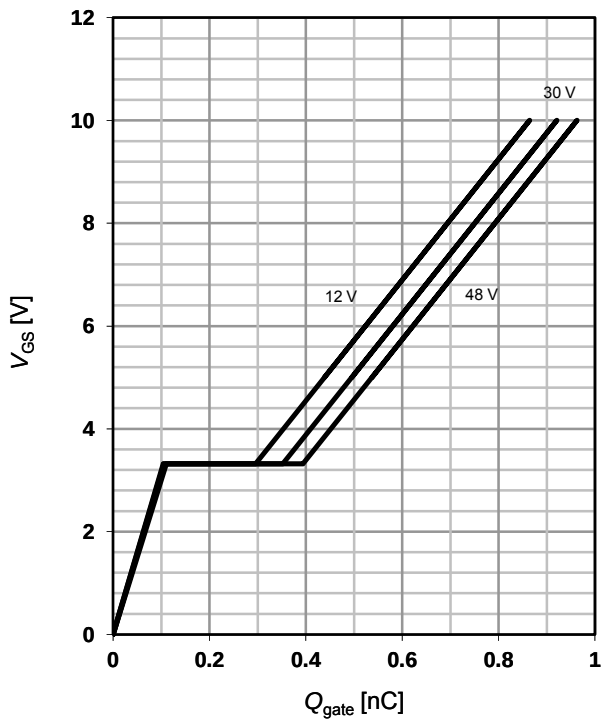
parameter:  $T_j$



### 13 Typ. gate charge

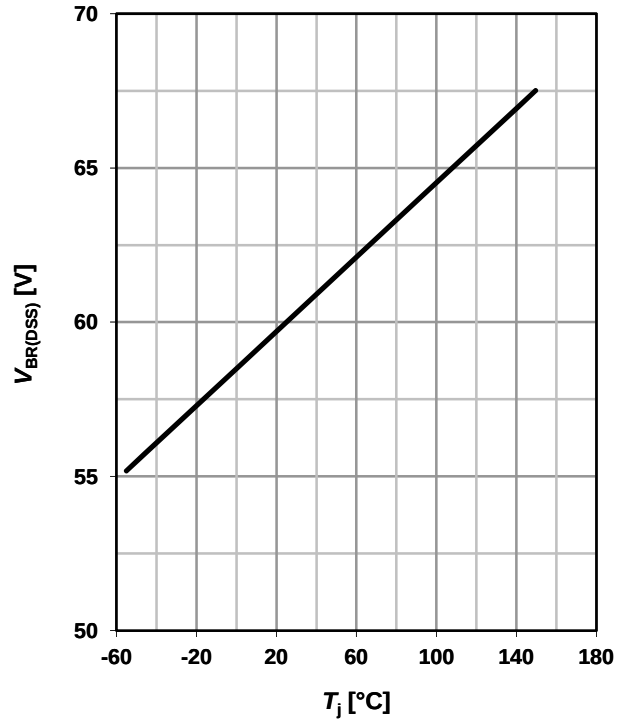
$V_{GS}=f(Q_{gate}); I_D=0.23\text{ A pulsed}$

parameter:  $V_{DD}$

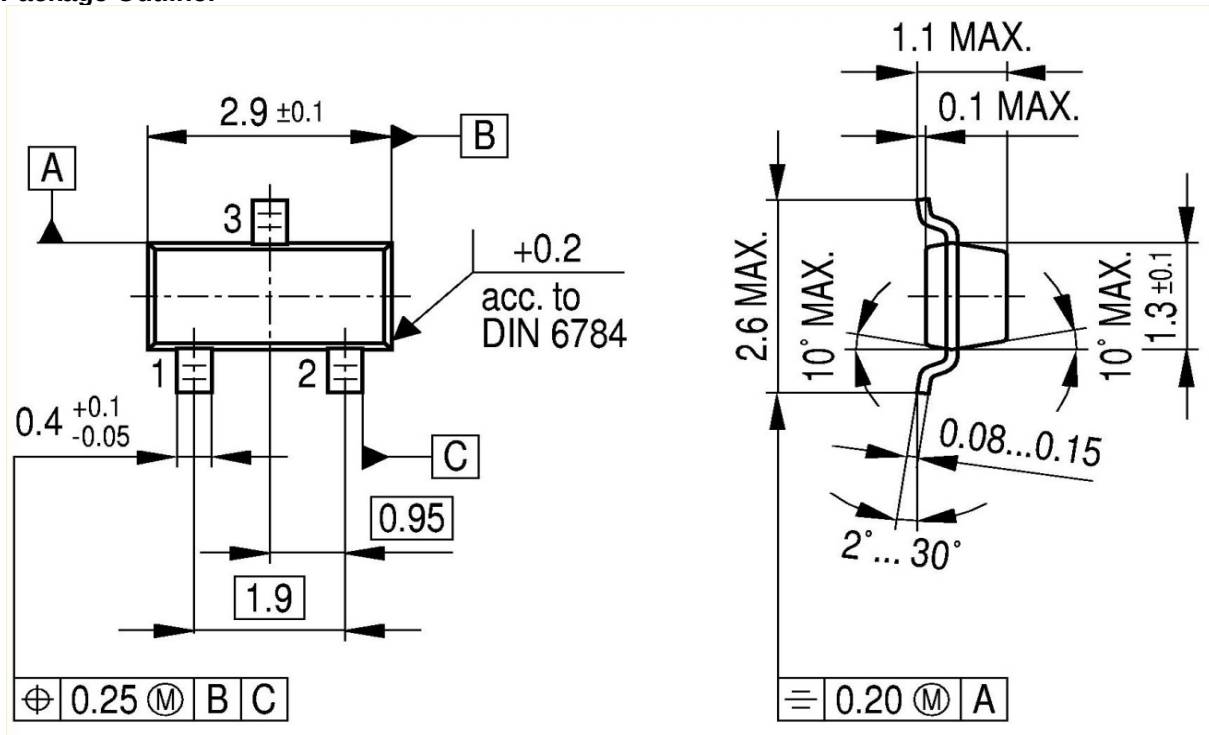


### 14 Drain-source breakdown voltage

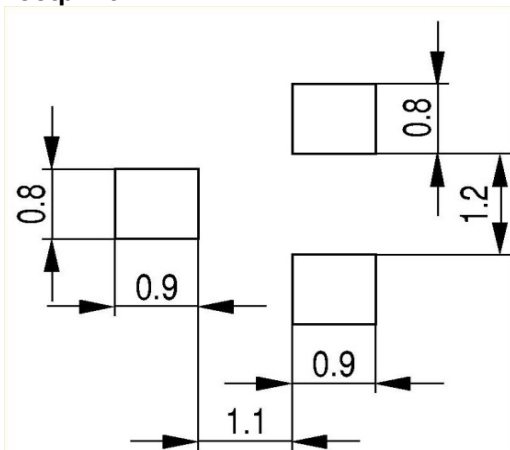
$V_{BR(DSS)}=f(T_j); I_D=250\text{ }\mu\text{A}$



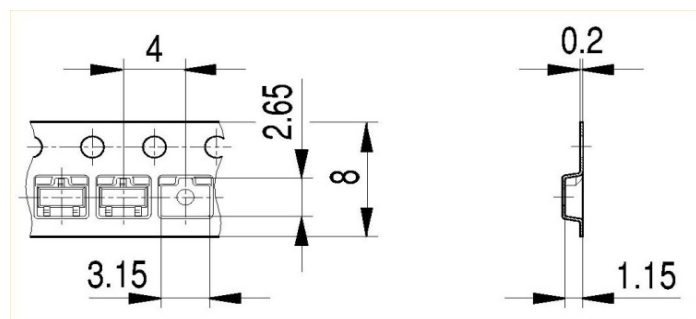
# Package Outline:



# Footprint:



# Packaging:



Dimensions in mm

**Published by**  
**Infineon Technologies AG**  
**Bereich Kommunikation**  
**St.-Martin-Straße 53**  
**D-81541 München**  
**© Infineon Technologies AG 1999**  
**All Rights Reserved.**

**Attention please!**

The information herein is given to describe certain components and shall not be considered as warranted characteristics.

Terms of delivery and rights to technical change reserved.

We hereby disclaim any and all warranties, including but not limited to warranties of non-infringement, regarding circuits, descriptions and charts stated herein.

Infineon Technologies is an approved CECC manufacturer.

**Information**

For further information on technology, delivery terms and conditions and prices, please contact your nearest Infineon Technologies office in Germany or our Infineon Technologies representatives worldwide (see address list).

**Warnings**

Due to technical requirements, components may contain dangerous substances.  
For information on the types in question, please contact your nearest Infineon Technologies office.

Infineon Technologies' components may only be used in life-support devices or systems with the expressed written approval of Infineon Technologies if a failure of such components can reasonably be expected to cause the failure of that life-support device or system, or to affect the safety or effectiveness of that device or system. Life support devices or systems are intended to be implanted in the human body, or to support and/or maintain and sustain and/or protect human life. If they fail, it is reasonable to assume that the health of the user or other persons may be endangered.



**Стандарт  
Электрон  
Связь**

Мы молодая и активно развивающаяся компания в области поставок электронных компонентов. Мы поставляем электронные компоненты отечественного и импортного производства напрямую от производителей и с крупнейших складов мира.

Благодаря сотрудничеству с мировыми поставщиками мы осуществляем комплексные и плановые поставки широчайшего спектра электронных компонентов.

Собственная эффективная логистика и склад в обеспечивает надежную поставку продукции в точно указанные сроки по всей России.

Мы осуществляем техническую поддержку нашим клиентам и предпродажную проверку качества продукции. На все поставляемые продукты мы предоставляем гарантию .

Осуществляем поставки продукции под контролем ВП МО РФ на предприятия военно-промышленного комплекса России , а также работаем в рамках 275 ФЗ с открытием отдельных счетов в уполномоченном банке. Система менеджмента качества компании соответствует требованиям ГОСТ ISO 9001.

Минимальные сроки поставки, гибкие цены, неограниченный ассортимент и индивидуальный подход к клиентам являются основой для выстраивания долгосрочного и эффективного сотрудничества с предприятиями радиоэлектронной промышленности, предприятиями ВПК и научно-исследовательскими институтами России.

С нами вы становитесь еще успешнее!

**Наши контакты:**

**Телефон:** +7 812 627 14 35

**Электронная почта:** [sales@st-electron.ru](mailto:sales@st-electron.ru)

**Адрес:** 198099, Санкт-Петербург,  
Промышленная ул, дом № 19, литера Н,  
помещение 100-Н Офис 331